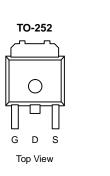
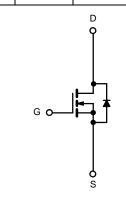


05N03LB-VB Datasheet N-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^{a, e}	Q _g (Typ)		
30	0.002 at V _{GS} = 10 V	100	72 nC		
- 50	0.003 at V _{GS} = 4.5 V	90	72110		





N-Channel MOSFET

FEATURES

- ٠ Trench Power MOSFET
- 100 % R_g and UIS Tested
- Compliant to RoHS Directive 2011/65/EU ٠

APPLICATIONS

- OR-ing
- Server
- DC/DC

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	30	V		
Gate-Source Voltage		V _{GS}	± 20	v	
	T _C = 25 °C		100 ^{a, e}	A	
Continuous Drain Current (T _J = 175 °C)	T _C = 70 °C		80 ^e		
$Continuous Drain Current (1_j = 175 C)$	T _A = 25 °C	I _D	35.8 ^{b, c}		
	T _A = 70 °C		27 ^{b, c}		
Pulsed Drain Current	I _{DM}	300	_		
Avalanche Current Pulse	L = 0.1 mH	I _{AS}	39		
Single Pulse Avalanche Energy	L = 0.1 mm	E _{AS}	94.8	mJ	
Continuous Source-Drain Diode Current	T _C = 25 °C		90 ^{a, e}	A	
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	3.13 ^{b, c}		
	T _C = 25 °C		235 ^a		
Mauiauna Daura Diasia stian	T _C = 70 °C	P	165		
Maximum Power Dissipation	T _A = 25 °C	P _D	3.75 ^{b, c}	W	
	T _A = 70 °C		2.63 ^{b, c}		
Operating Junction and Storage Temperature Ra	ange	T _J , T _{stg}	- 55 to 175	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Тур.	Max.	Unit	
Maximum Junction-to-Ambient ^{b, d}	$t \le 10 \text{ sec}$	R _{thJA}	32	40	°C/W	
Maximum Junction-to-Case	Steady State	R _{thJC}	0.5	0.6	0/10	

Notes:

a. Based on $T_C = 25 \text{ °C}$. b. Surface mounted on 1" x 1" FR4 board.

a. t = 10 sec.
d. Maximum under steady state conditions is 90 °C/W.
e. Calculated based on maximum junction temperature. Package limitation current is 90 A.



	SPECIFICATIONS (T _J = 25 °C,				-	_ _	
$\begin{array}{c c c c c c c c c c c c c c c c c c c $		Symbol	Test Conditions	Min.	Тур.	Max.	Unit
$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$		V	V 0.V 1 250 ··· 4			1	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	6		$v_{GS} = 0 v, I_D = 250 \mu A$	30	0.5		V
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $			I _D = 250 μA				mV/°
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $. ,			- 7.5		
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	5			1.5		2.5	V
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Gate-Source Leakage	I _{GSS}				± 100	nA
$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$	Zero Gate Voltage Drain Current	loss	50 00			1	μA
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $		-033				10	
$\begin{array}{ c c c c c c c c c c c c c c c c c c c$	On-State Drain Current ^a	I _{D(on)}		90			Α
$ \begin{array}{ c c c c c } \hline V_{GS} = 4.5 \ V, \ v_{DS} = 37 \ A \\ \hline 0.003 $	Drain Source On State Desistence	Base	V _{GS} = 10 V, I _D = 38.8 A	0.002			0
	Drain-Source On-State Resistance-	''DS(on)	$V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 37 \text{ A}$		0.003		52
$ \begin{array}{ c c c c c c c } \hline Input Capacitance & C_{IBS} \\ \hline Output Capacitance & C_{GSS} \\ \hline Output Capacitance & C_{rss} \\ \hline Output Cap$	Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 38.8 A		160		S
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Dynamic ^b						
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Input Capacitance	C _{iss}			5201		
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Output Capacitance	C _{oss}	V_{DS} = 15 V, V_{GS} = 0 V, f = 1 MHz		1525		pF
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Reverse Transfer Capacitance	C _{rss}			770		
$ \begin{array}{ c c c c c c } \hline \begin{tabular}{ c c c c c } \hline \begin{tabular}{ c c c c c c } \hline \begin{tabular}{ c c c c c c } \hline \begin{tabular}{ c c c c c c c } \hline \begin{tabular}{ c c c c c c c } \hline \begin{tabular}{ c c c c c c c } \hline \begin{tabular}{ c c c c c c c c c c c c c c c c c c c$	Tatal Oats Observe	0	$V_{DS} = 15 \text{ V}, \text{ V}_{GS} = 10 \text{ V}, \text{ I}_{D} = 38.8 \text{ A}$		151	227	3
$ \begin{array}{ c c c c c } \hline Gate-Source Charge & $ $ $ $ $ $ $ $ $ $ $ $ $ $ $ $ $ $ $	Total Gate Charge	Qg			71.5	103	
$ \begin{array}{c c c c c c c c c c } \hline Gate Resistance & R_g & f = 1 \ MHz & 1.4 & 2.1 & \Omega \\ \hline Turn-On Delay Time & t_d(on) & & & & & & & & & & & & & & & & & & &$	Gate-Source Charge	Q _{gs}	V_{DS} = 15 V, V_{GS} = 4.5 V, I_{D} = 28.8 A		30		
$ \begin{array}{c c c c c c c c c c } \hline Turn-On Delay Time & t_{d(on)} \\ \hline Rise Time & t_r & V_{DD} = 15 \ V, \ R_L = 0.625 \ \Omega & 11 & 17 \\ \hline I_D \equiv 24 \ A, \ V_{GEN} = 10 \ V, \ R_g = 1 \ \Omega & 70 & 105 \\ \hline I_D \equiv 24 \ A, \ V_{GEN} = 10 \ V, \ R_g = 1 \ \Omega & 70 & 105 \\ \hline I_D \equiv 24 \ A, \ V_{GEN} = 10 \ V, \ R_g = 1 \ \Omega & 70 & 105 \\ \hline Turn-On Delay Time & t_f & 10 & 15 \\ \hline Turn-On Delay Time & t_r & V_{DD} = 15 \ V, \ R_L = 0.67 \ \Omega & 180 & 270 \\ \hline I_D \equiv 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 55 & 83 \\ \hline Fall Time & t_f & 12 & 18 \\ \hline \hline Drain-Source Body Diode Characteristics & & & & & \\ \hline Drain-Source Body Diode Characteristics & & & & & & & & \\ \hline Continuous Source-Drain Diode Current & I_S & T_C = 25 \ C & & & & & & & & & & & & \\ \hline Pulse Diode Forward Current^a & I_{SM} & & & & & & & & & & & & \\ \hline Body Diode Reverse Recovery Time & t_r & & & & & & & & & & & & & \\ \hline Body Diode Reverse Recovery Charge & Q_{rr} & & & & & & & & & & & & & \\ \hline Reverse Recovery Fall Time & t_a & & & & & & & & & & & & & & & \\ \hline \end{array}$	Gate-Drain Charge	Q _{gd}			24		
$\begin{array}{ c c c c c } \hline Rise Time & t_r & V_{DD} = 15 \ V, \ R_L = 0.625 \ \Omega & 11 & 17 \\ \hline I_D \cong 24 \ A, \ V_{GEN} = 10 \ V, \ R_g = 1 \ \Omega & 10 & 15 \\ \hline I_D \cong 24 \ A, \ V_{GEN} = 10 \ V, \ R_g = 1 \ \Omega & 10 & 15 \\ \hline I_D \cong 24 \ A, \ V_{GEN} = 10 \ V, \ R_g = 1 \ \Omega & 10 & 15 \\ \hline I_D \cong 22 \ A, \ V_{GEN} = 10 \ V, \ R_g = 1 \ \Omega & 10 & 15 \\ \hline I_D \cong 22 \ S \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 55 & 83 \\ \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 55 & 83 \\ \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 12 & 18 \\ \hline \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 12 & 18 \\ \hline \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 12 & 18 \\ \hline \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 12 & 18 \\ \hline \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 12 & 18 \\ \hline \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 12 & 18 \\ \hline \hline \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 12 & 18 \\ \hline \hline \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 12 & 18 \\ \hline \hline \hline \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 12 & 12 \\ \hline \hline \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 12 & 12 \\ \hline \hline \hline \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 12 & 18 \\ \hline \hline \hline \hline \hline \hline I_D \cong Diode \ Forward \ Current^a \ I_S \$	Gate Resistance	R _g	f = 1 MHz		1.4	2.1	Ω
$\begin{array}{ c c c c c } \hline Rise Time & t_r & V_{DD} = 15 \ V, \ R_L = 0.625 \ \Omega & 11 & 17 \\ \hline I_D \cong 24 \ A, \ V_{GEN} = 10 \ V, \ R_g = 1 \ \Omega & 10 & 15 \\ \hline I_D \cong 24 \ A, \ V_{GEN} = 10 \ V, \ R_g = 1 \ \Omega & 10 & 15 \\ \hline I_D \cong 24 \ A, \ V_{GEN} = 10 \ V, \ R_g = 1 \ \Omega & 10 & 15 \\ \hline I_D \cong 22 \ A, \ V_{GEN} = 10 \ V, \ R_g = 1 \ \Omega & 10 & 15 \\ \hline I_D \cong 22 \ S \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 55 & 83 \\ \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 55 & 83 \\ \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 12 & 18 \\ \hline \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 12 & 18 \\ \hline \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 12 & 18 \\ \hline \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 12 & 18 \\ \hline \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 12 & 18 \\ \hline \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 12 & 18 \\ \hline \hline \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 12 & 18 \\ \hline \hline \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 12 & 18 \\ \hline \hline \hline \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 12 & 12 \\ \hline \hline \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 12 & 12 \\ \hline \hline \hline \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 12 & 18 \\ \hline \hline \hline \hline \hline \hline I_D \cong Diode \ Forward \ Current^a \ I_S \$	Turn-On Delay Time	t _{d(on)}			18	27	
$ \begin{array}{c c c c c c c c c c c c } \hline Turn-Off Delay Time & t_{d(off)} & I_D \cong 24 \text{ A}, \ V_{GEN} = 10 \text{ V}, \ R_g = 1 \Omega & 70 & 105 \\ \hline Turn-On Delay Time & t_{d(on)} & & & & & & & & & & & & & & & & & & &$	Rise Time		$V_{DD} = 15 \text{ V}, \text{ R}_{1} = 0.625 \Omega$		11	17	-
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Turn-Off Delay Time	t _{d(off)}	$I_D \cong 24 \text{ A}, \text{ V}_{\text{GEN}} = 10 \text{ V}, \text{ R}_{\text{g}} = 1 \Omega$		70	105	
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	Fall Time	. ,			10	15	
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	Turn-On Delay Time	t _{d(on)}			55	83	ns
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Rise Time		V _{DD} = 15 V, R _I = 0.67 Ω		180	270	
Fall Time t_f 1218Drain-Source Body Diode Characteristics t_f 1218Drain-Source Body Diode Characteristics $T_C = 25 ^{\circ}C$ 120 A Continuous Source-Drain Diode Current I_S $T_C = 25 ^{\circ}C$ 120 A Pulse Diode Forward Current ^a I_{SM} 120 A Body Diode Voltage V_{SD} $I_S = 22 ^{A}$ 0.8 1.2 V Body Diode Reverse Recovery Time t_{rr} $F_r = 20 ^{A}$, di/dt = 100 A/\mus , $T_J = 25 ^{\circ}C$ 70.2 105 nC Reverse Recovery Fall Time t_a T_a 27 ns ns	Turn-Off Delay Time				55	83	-
Drain-Source Body Diode CharacteristicsContinuous Source-Drain Diode CurrentIs $T_C = 25 \text{ °C}$ 120Pulse Diode Forward Current ^a IsM120ABody Diode Voltage V_{SD} $I_S = 22 \text{ A}$ 0.81.2VBody Diode Reverse Recovery Time t_{rr} 52 78nsBody Diode Reverse Recovery Charge Q_{rr} $I_F = 20 \text{ A}$, di/dt = 100 A/µs, $T_J = 25 \text{ °C}$ 70.2105nCReverse Recovery Fall Time t_a T_a T_{rr} T_{rr} T_{rr} T_{rr}			- 9				
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Drain-Source Body Diode Characteristic				I		
Pulse Diode Forward Current ^a Ism120ABody Diode Voltage V_{SD} $I_S = 22 \text{ A}$ 0.81.2VBody Diode Reverse Recovery Time t_{rr} 5278nsBody Diode Reverse Recovery Charge Q_{rr} $I_F = 20 \text{ A}$, di/dt = 100 A/µs, $T_J = 25 \text{ °C}$ 70.2105nCReverse Recovery Fall Time t_a t_a 27 ns	Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			120	
Body Diode Voltage V_{SD} $I_S = 22 \text{ A}$ 0.81.2VBody Diode Reverse Recovery Time t_{rr} 5278nsBody Diode Reverse Recovery Charge Q_{rr} $I_F = 20 \text{ A}, di/dt = 100 \text{ A/µs}, T_J = 25 °C$ 70.2105nCReverse Recovery Fall Time t_a r_a r_a r_a r_a r_a r_a	Pulse Diode Forward Current ^a				1	120	A
Body Diode Reverse Recovery Time t_{rr} 5278nsBody Diode Reverse Recovery Charge Q_{rr} Reverse Recovery Fall Time t_a			I _S = 22 A		0.8		V
Body Diode Reverse Recovery Charge Q_{rr} Reverse Recovery Fall Time t_a	, 0		-				ns
Reverse Recovery Fall Time t_a $I_F = 20 \text{ A}, dl/dt = 100 \text{ A}/\mu\text{s}, I_J = 25 \text{ °C}$ 27 ns							
ns ns			$I_F = 20 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 \text{ °C}$	-			
	Reverse Recovery Rise Time	t _b			25		ns

Notes:

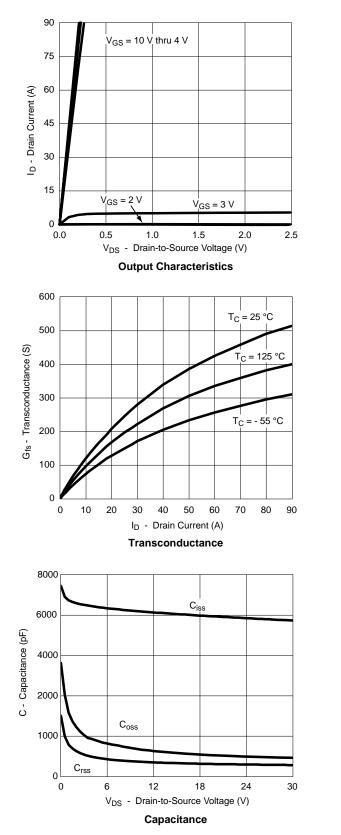
a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.

b. Guaranteed by design, not subject to production testing.

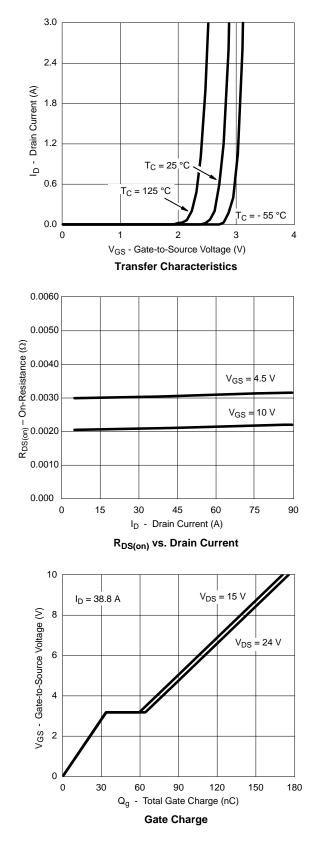
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Bsemi



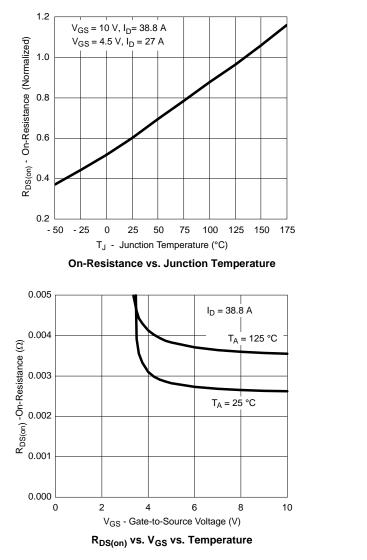


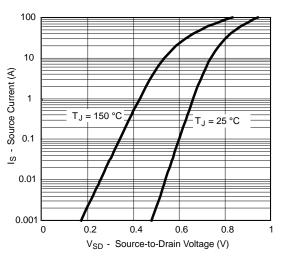
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



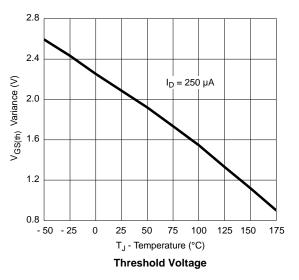


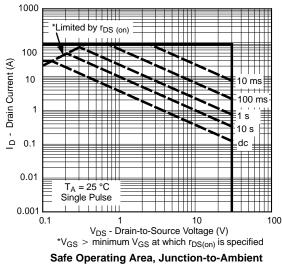




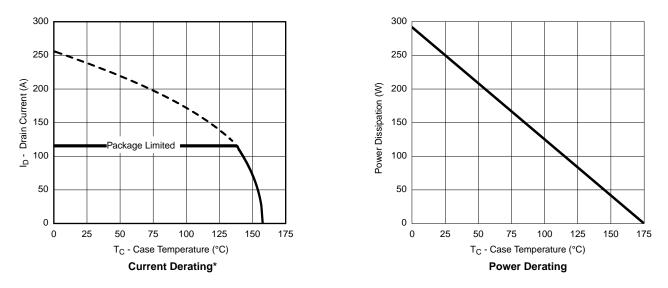


Forward Diode Voltage vs. Temperature









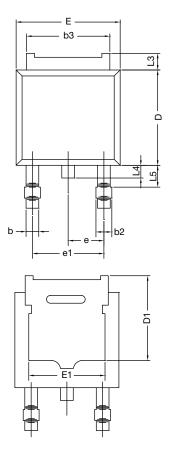
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

*The power dissipation P_D is based on $T_{J(max)} = 175$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





TO-252AA CASE OUTLINE





	MILLIN	IETERS	INC	HES	
DIM.	MIN.	MAX.	MIN.	MAX.	
А	2.18	2.38	0.086	0.094	
A1	-	0.127	-	0.005	
b	0.64	0.88	0.025	0.035	
b2	0.76	1.14	0.030	0.045	
b3	4.95	5.46	0.195	0.215	
С	0.46	0.61	0.018	0.024	
C2	0.46	0.89	0.018	0.035	
D	5.97	6.22	0.235	0.245	
D1	5.21	-	0.205	-	
Е	6.35	6.73	0.250	0.265	
E1	4.32	-	0.170	-	
Н	9.40	10.41	0.370	0.410	
е	2.28	BSC	0.090 BSC		
e1	4.56	BSC	0.180 BSC		
L	1.40	1.78	0.055	0.070	
L3	0.89	1.27	0.035	0.050	
L4	-	1.02	-	0.040	
L5	1.14	1.52	0.045	0.060	
ECN: X12- DWG: 534	0247-Rev. M, 7	24-Dec-12			

Note

• Dimension L3 is for reference only.



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Please note that some documents may still refer to Taiwan VBsemi RoHS Directive 2002/95 / EC. We confirm that all products identified as consistent with the Directive 2002/95 / EC European Directive 2011/65 /.

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